

Notice of References Cited	Application/Control No. 10/708,211	Applicant(s)/Patent Under Reexamination CHIOU ET AL.	
	Examiner Christopher Verdier	Art Unit 3745	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,751,097 B1	06-2004	Lin et al.	361/695
	B	US-6,439,299 B1	08-2002	Miyahara et al.	165/121
	C	US-6,408,934 B1	06-2002	Ishida et al.	165/80.3
	D	US-5,727,624 A	03-1998	Ko et al.	165/121
	E	US-6,328,097 B1	12-2001	Bookhardt et al.	165/80.3
	F	US-2004/0079520 A1	04-2004	Lee	165/122
	G	US-6,688,379 B2	02-2004	Huang et al.	165/121
	H	US-6,637,501 B2	10-2003	Lin et al.	165/80.3
	I	US-6,574,101 B2	06-2003	Tanaka et al.	361/697
	J	US-6,311,767 B1	11-2001	Inoue et al.	165/80.3
	K	US-6,132,170 A	10-2000	Hornig	415/178
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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